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Enclosed are the results from the Open Network Systems Interoperability performed on:

Module or Cable Assembly Under Test (MUT/CUT):

Vendor and Device Type	10Gtek QSFP
Part Number	AMQ10-SR4-M1

Host Under Test (HUT):

Host System 1 Composition	
Network Operating System	Cumulus
OS Version	3.5
Bare Metal Switch	Edge-Core 7712
Part Number	7712
ONIE Version	2018.02

This testing pertains to the Open Network Systems Interoperability Test Plan, which outlines a series of tests performed on a variety of optical transceivers and cables with bare-metal open switches running Network Operating Systems from multiple vendors. The focus of these tests was basic interoperability, which aims to validate the operation of open network systems.

As always, we welcome any comments regarding this Test Suite. If you have any questions about the test procedures or results, please feel free to contact me via e-mail at <u>david@iol.unh.edu</u> or by phone at +1-603-862-0090.

Regards, David Woolf

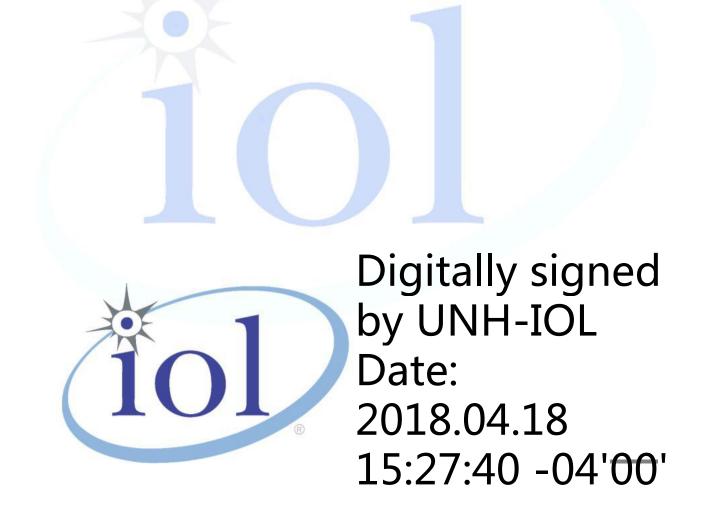
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In section 2, the following equipment was used:

Test System Hardware	
EEPROM Reader	I2C Elite Reader

In section 3, the following equipment was used:

Test System Hardware	
Network Analyzer	PNA –Performance Network Analyzer

In section 4, the following equipment was used:

Test System Hardware		
Wide Bandwidth	Keysight DCA-X 86100D Wide Bandwidth Oscilloscope	
Oscilloscope		
Waveform Analyzer	Keysight 86105C Optical Waveform Analyzer	
50GHz Waveform Analyzer	Keysight 86108B Mega Module, 50GHz Bandwidth Waveform Analyzer	
Clock Recovery Module	Keysight 83496B Optical/Electrical Clock Data Recovery Unit	
High Performance Serial BERT	Tektronix BERTScope	
Signal Quality Analyzer	BERTScope PRBS9 at 10.3125Gbps	
De-Emphasis Signal	Agilent N4916B	
Converter		

\*Two modules used during testing

In section 6, an Ixia XM12 was used to generate test traffic:

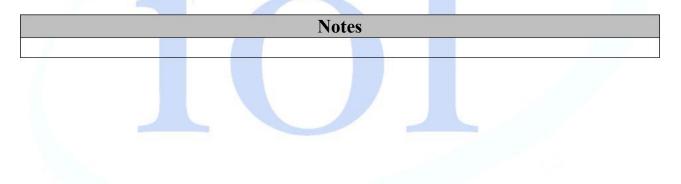
Test System Hardware	
Ethernet Traffic Generator	Ostinato Software
Software Version	Ostinato
Port Types	40/100G

Result	Interpretation
PASS	The Device Under Test (DUT) was observed to exhibit conformant behavior.
PASS W/ Comments	The specified behavior is demonstrated by the DUT; however this result indicates that either changes were made to the standard test procedure or results other than the expected results were observed.
FAIL	The DUT was observed to exhibit non-compliant behavior.
INFO	This Test is designed for informational purposes only. While the results may help ensure the interoperability of the DUT, a PASS/FAIL is not given for this test.
WARN	The DUT was observed to exhibit behavior that is not recommended.
N/A	Not Applicable. This test is not applicable for the DUT.
N/S	Not Supported. This test was not run due to features not implemented on the DUT.
N/T	Not tested. This test was not run.

The following table contains possible results and their meanings.

Summary of Results- Conformance	
Test	Result
Test 1.1:	N/A
Test 1.2:	PASS
Test 3.1.1: Return Loss for 10G Passive Cable	PASS
Test 3.1.2: Insertion Loss for 10G Passive Cable	PASS
Test 5.1.1: Output Rise and Fall Times for 100G Host	PASS
Test 5.1.2: Transmitter Eye Mask for 100G Host	PASS
Test 5.1.3: Total Jitter for 100G Host	PASS
Test 5.1.4: Input and Output Return Loss on 100G Host	PASS

Summary of Results - Interoperability		
Test	Result	
Test 2.1: Physical Compatibility with Supporting Devices	PASS	
Test 2.2: Host Management of Module or Cable Assembly	PASS	
Test 2.3: Diagnostic Optical Monitor Support	PASS	
Test 6.1: Establish Baseline Performance Analysis	PASS	
Test 6.2:	PASS	
Test 6.3:Packet Error Rate Estimation	PASS	
Test 6.4: Packet Loss/Stress Test	PASS	



2.2

<b>Conformance Test Results</b>	
Test Information	Test Result
Test 1.1:	
<i>Purpose</i> : To verify that a host can pass a random sampling of ONIE Complian Environment tests.	Ice N/A
Comments on Test Procedure	
The random sampling of tests from the ONIE Compliance Environment was not used.	
Comments on Test Results	
Additional Comments	
This test is only applicable to Hosts which have not performed ONIE previously.	compliance testing
Test Information	Test Result
Test 1.2:	
<i>Purpose</i> : To verify that a NOS can be successfully installed through ONIE.	PASS
Comments on Test Procedure	
This test was completed using the standard procedure as written in the Test Plan. The the ONIE Compliance Environment was not used.	random sampling of tests fro
Comments on Test Results	
<b>Part A:</b> The DUT was able to install the NOS via ONIE.	

Part B: The DUT was able to uninstall the NOS via ONIE.

#### **Additional Comments**

Test Information	Test Result
Test 3.1.1: Return loss for 10G Passive Cable	
<i>Purpose</i> : To verify that the return loss of the DUT is within the conformance limits provided by SFF-8431 Appendix E, Table 37.	PASS
Comments on Test Procedure	
This test was completed using the standard procedure.	
Comments on Test Results	
The differential return loss observed did not violate the limits governed by SFF-8431 Appendi 10GBASE-CR passive cables: $12 - 2\sqrt{-},  0.01 \le < 4.1$ $11,  22 \ge \{ 6.3 - 13 \log_{10} 5.5, 4.1 \le \le 11.1 \} $	
Additional Comments	
Test Information	Test Result
Test 3.1.2: Insertion Loss for 10G Passive Cable	
<i>Purpose</i> : To verify that the insertion loss of the Cable under test is within the conformance limits provided by IEEE Std. 802.3-2012 Annex, Table 37.	PASS
Comments on Test Procedure	
This test was completed using the standard procedure.	
Comments on Test Results	
The insertion loss of the cable under test does not violate the requirements passive cable assent	nblies.
$3 \leq 21, 12 \leq 17.04$ , 5.15625	
Additional Comments	

Test Information	Test Result
Test 5.1.1: Output Rise and Fall Times for 10G Host	
<i>Purpose</i> : To verify that the Eye Mask Hit Ratio is within the conformance limits.	PASS
Comments on Test Procedure	
The test was completed with the standard procedure.	
Comments on Test Results	8
The device under test exhibited the expected behavior.	
Additional Comments	
Test Information	Test Result
Test 5.1.2: <b>Transmitter Eye Mask on 10G Host</b> <i>Purpose</i> : To verify that the Eye Mask Hit Ratio is within the conformance limits.	PASS
Comments on Test Procedure	
The test was completed with the standard procedure.	6.8
Comments on Test Results	
The device under test exhibited the expected behavior.	
Additional Comments	

Test Information	Test Result
Test 5.1.3:	
Purpose: To verify that the Total Jitter (TJ) is within the confe	PASS PASS
Comments on Test Procedure	
The test was completed with the standard procedure.	
Comments on Test Results	
The device under test exhibited the expected behavior.	
Additional Comments	
Test Information	Test Result

Test Information	Test Result
Test 5.1.4: Input and Output Return Loss on 10G Host	
<i>Purpose</i> : To verify that the differential input and output return loss of the DUT is within conformance limits.	PASS
Comments on Test Procedure	
The test was completed with the standard procedure. Comments on Test Results The device under test exhibited the expected behavior.	
Additional Comments	
See Appendix B	

Interoperability Test Results	
Test Information	Test Result
Test 2.1: Physical Compatibility with Supporting Devices	
<i>Purpose</i> : To verify that the mechanical form factor is compatible with devices for interoperability purposes.	PASS
Comments on Test Procedure	
The test was completed with the standard procedure.	
Comments on Test Results	
<ul><li>Part A: The MUT/CUT was able to be inserted into the Host.</li><li>Part B: This test is not applicable to Cable Assemblies.</li><li>Part C: The MUT/CUT was able to be removed from the Host.</li></ul>	
Additional Comments	
Test Information	Test Result

lest Information	Test Result
Test 2.2: <i>Purpose</i> : To verify that the MUT/CUT is manageable via the Host complex.	PASS
Comments on Test Procedure	
The test was completed with the standard procedure.	
Comments on Test Results	
<b>Part B:</b> The EEPROM data of the MUT/CUT was readable. The serial number and v from the EEPROM data matches the serial number and vendor information of	

#### **Additional Comments**

Test Information	Test Result
Test 2.3: <i>Purpose</i> : To verify that the MUT/CUT (active optical cable only) supports diagnostic functions via the Host complex.	PASS
Comments on Test Procedure	
The test was completed with the standard procedure.	
Comments on Test Results	
<b>Part A:</b> The MUT/CUT supports diagnostic monitoring and the diagnostic information from t readable by the NOS.	he EEPROM was
Additional Comments	

Test Information	Test Result
Test 6.1: Establish Baseline Performance Analysis <i>Purpose</i> : To establish a baseline performance analysis of the HUT.	PASS
Comments on Test Procedure	
This test was completed using a modified procedure. Because of a lack of 40G Golden Mode baselined using each 40G MUT/CUT.	les, the Host was
Comments on Test Results	
The baseline performance of the Host was determined to be 90% line rate. All proceeding te conducted using this line rate.	sts in Group 6 were
Additional Comments	
Test Information	Test Result
Test 6.2: <i>Purpose</i> : To determine if the MUT/CUT, HUT and LP establish a link while varying the power up sequence.	PASS
Comments on Test Procedure	
This test was completed using the standard procedure.	
Comments on Test Results	

Part A: The Host and Link Partner were able to establish a valid link with this MUT/CUT while fully powered and operational.

- **Part B:** The Host and Link Partner were able to establish a valid link with this MUT/CUT when the Link Partner was powered on after the Host.
- **Part C:** The Host and Link Partner were able to establish a valid link with this MUT/CUT when the Host was powered on after the Link Partner.

#### **Additional Comments**

Test Information	Test Result
Test 6.3:Packet Error Rate Estimation	
<i>Purpose</i> : To determine if a Host can exchange packets with a Module or Cable Assembly such that a bit error rate of $10^{-12}$ is achieved	PASS
Comments on Test Procedure	
This test was completed using the standard procedure.	
Comments on Test Results	
<b>Part A:</b> All 247,000,000 frames transmitted by TS1 were received by TS2. <b>Part B:</b> All 10,506,539,320 frames transmitted by TS1 were received by TS2.	
Additional Comments	

Test 6.4: Packet Loss/Stress Test         Purpose: To verify that no obvious buffer management problems occur when directing a large volume of traffic at the Host and Module/Cable Assembly combination.         Comments on Test Procedure         This test was completed using the standard procedure.         Comments on Test Results         Parts A-D: All 1,000,000,000 64-byte frames transmitted by TS1 were received by TS2. All 1,000,000 1518-byte frames transmitted by TS1 were received by TS2.	lesult
This test was completed using the standard procedure. Comments on Test Results Parts A-D: All 1,000,000,000 64-byte frames transmitted by TS1 were received by TS2.	PASS
Comments on Test Results Parts A-D: All 1,000,000,000 64-byte frames transmitted by TS1 were received by TS2.	
Parts A-D: All 1,000,000,000 64-byte frames transmitted by TS1 were received by TS2.	
Additional Comments	

#### **Appendix A: EEPROM Data**

10Gtek QSFP+ module Part Number: AMQ10-SR4-M1 Serial Number: WTQSRHB0075 10Gtek WTQSRHB0075 EEPROMdecode 20180320203619.txt SERIAL ID Keys: BR NOMINAL: 10300 CONNECTOR: 12 CU ATTENUATE 2 5: 0 CU ATTENUATE 5 0: 0 DEVICE TECH: 0x0 ENCODING: 5 EXTENDED MODULE: 0x7 EXT IDENTIFIER: 0 EXT RATE COMPLY: 0 IDENTIFIER: 13 LENGTH OM1 62 5UM: 0 LENGTH OM2 50UM: 0 LENGTH OM3 50UM: 100 LENGTH OM4 OR CU: 0 LENGTH SMF KM: 0 MAX CASE TEMP: 70 SPEC COMPLIANCE: 0x4 0x0 0x0 0x0 0x0 0x0 0x0 0x0 VENDOR NAME: 10Gtek VENDOR OUI: 0x0 0x0 0x0 VENDOR PN: AMQ10-SR4-M1 VENDOR REV: 01 WAVELENGTH: 850.0 WAVELEN TOLERANCE: 0.0 I2C Address A0h, bytes 0-127, in hex 0000x: 0d00000f 0000000 00555500 00000000 0010x: 0000000 00002000 00007cce 00000000 0020x: 00000001 00010001 000108a6 08ad08c4 0030x: 08f61e45 1e5d1eae 1f5d0000 00000000 0040x: 0000000 0000000 0000000 0000000 0050x: 0000000 0000000 0000000 0000000 0060x: 0000000 0000000 0000000 0000000 0070x: 0000000 0000000 0000000 0000000 I2C Address A0h, page 0, bytes 128-255, in hex 0000x: 0d000c04 0000000 0000005 67000032 0010x: 0000000 31304774 656b2020 20202020 0020x: 20202020 07000000 414d5131 302d5352 0030x: 342d4d31 20202020 30314268 000046b0 0040x: 0000000 57545153 52484230 30373520 0050x: 20202020 31373131 30312020 0800000a 0060x: 0000000 0000000 0000000 0000000 0070x: 0000000 0000000 0000000 0000000

## Appendix B: Pluggable Module / Cable Electrical Data

Optics Self-Test Report - Port 1: 100GigE Layer 2 Traffic Term

Generated by Viavi 5800-100G

# **Optics Self-Test**

Customer Name	
Technician ID	
Test Location	==)
Work Order	**
Comments/Notes	am)

## **Overall Test Result: Pass**

